

## 75V 0.4A Fast Switching Diode - 1N3600

Small-Signal high speed switching diode in bare die form

Rev 1.1 24/10/24

#### Features:

- Fast Switching Speed
- High conductance
- General purpose switching applications
- High reliability tested grades.

#### **Ordering Information**

The following part suffixes apply:

- No suffix MIL-STD-750 /2073 Visual Inspection
- "H" MIL-STD-750 /2073 Visual Inspection+ MIL-PRF-38534 Class H LAT
- "K" MIL-STD-750 /2073 Visual Inspection+ MIL-PRF-38534 Class K LAT

LAT = Lot Acceptance Test.

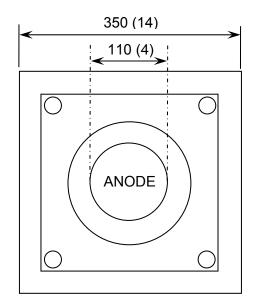
For further information on LAT process flows see below.

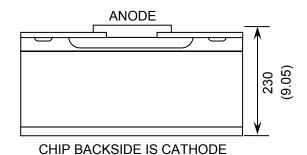
www.siliconsupplies.com\quality\bare-die-lot-qualification

#### **Supply Formats:**

- Default Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape By specific request
- Unsawn Wafer By specific request
- Die Thickness <> 230µm(9 Mils) On request
- With additional electrical selection On request

#### Die Dimensions in µm (mils)





#### **Mechanical Specification**

Die Size (Unsawn)	350 x 350 13.78 x 13.78	µm mils
Anode Pad Size	110 Ø 4.33 Ø	μm mils
Die Thickness	230 (±15) 9.05 (±0.59)	μm mils
Top Metal Composition	Al	
Back Metal Composition	AuAs	





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### Absolute Maximum Ratings<sup>1</sup> T<sub>J</sub> = 25°C unless otherwise stated

PARAMETER	SYMBOL	VALUE		UNIT
Repetitive Peak Reverse Voltage	$V_{RRM}$	75		V
Working Inverse Voltage	$V_{RWM}$	50		V
Average Rectified Forward Current	Io	200		mA
DC Forward Current	l <sub>F</sub>	400		mA
Recurrent Peak Forward Current	I <sub>f</sub>	600		mA
Non-repetitive Peak forward surge current	I <sub>FSM</sub>	Pulse width 1s	1	A
		Pulse width 1µs	4	
Power Dissipation	$P_{D}$	500		mW
Operating Junction temperature	$T_J$	-55 to 175		°C
Storage Temperature Range	T <sub>STG</sub>	-65 to 200		°C

<sup>1.</sup> Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability.

#### Electrical Characteristics T<sub>.I</sub> = 25°C unless otherwise stated

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT	
Breakdown Voltage	V <sub>R</sub>	I <sub>R</sub> = 5μA	75	-	-	V	
Forward Voltage <sup>2</sup> V <sub>F</sub>		I <sub>F</sub> = 1mA	0.54	-	0.62	V	
		I <sub>F</sub> = 10mA	0.66	-	0.74		
	V <sub>F</sub>	I <sub>F</sub> = 50mA	0.76	-	0.86		
		I <sub>F</sub> = 100mA	0.82	-	0.92		
		I <sub>F</sub> = 200mA	0.87	-	1		
Reverse Leakage I <sub>R</sub>	lo.	V <sub>R</sub> = 50V	-	-	0.1	μA	
	'R	V <sub>R</sub> = 50V, T <sub>J</sub> = 150°C	-	-	100	μΛ	
Total Capacitance	Ст	$V_R = 0V$ , $f = 1MHz$	-	-	2	pF	
Reverse Recovery Time t <sub>rr</sub>	$I_F = I_R = 10 \text{mA} - 200 \text{mA}, R_L = 100 \Omega$	-	-	3			
	urr urr	$I_F = I_R = 200 \text{mA} - 400 \text{mA}, R_L = 100 \Omega$	-	-	6	ns	
Forward Recovery Time	t <sub>fr</sub>	I <sub>F</sub> = 200mA, V <sub>FR</sub> = 1V	-	-	10		

<sup>2.</sup> Pulse Width = 8.3ms, Non-recurrent square wave

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